Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10573166	TANAKA ET AL.
Examiner	Art Unit
Sheela J Huff	1643

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES			
Search Notes	Date	Examiner	
inventor serach on PALNM	10/21/08	sjh	
SCORE- SEQ ID NO. 2 and 3	10/21/08	sjh	
Stic structure search	10/21/08	sjh	
WEST-insert	10/21/08	sjh	
STN-inseret	10/21/08	sjh	

INTERFERENCE SEARCH			
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